

# MOS FIELD EFFECT TRANSISTOR $\mu PA1917$

## P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

### DESCRIPTION

The  $\mu$ PA1917 is a switching device which can be driven directly by a 1.8 V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

#### **FEATURES**

- 1.8 V drive available
- Low on-state resistance
- $\begin{array}{lll} {\sf R}_{\sf DS(on)1} = & 53 \mbox{ m}\Omega \mbox{ MAX.} ({\sf V}_{\sf GS} = -4.5 \mbox{ V}, \mbox{ I}_{\sf D} = -3.0 \mbox{ A}) \\ {\sf R}_{\sf DS(on)2} = & 70 \mbox{ m}\Omega \mbox{ MAX.} ({\sf V}_{\sf GS} = -2.5 \mbox{ V}, \mbox{ I}_{\sf D} = -3.0 \mbox{ A}) \\ {\sf R}_{\sf DS(on)3} = & 107 \mbox{ m}\Omega \mbox{ MAX.} ({\sf V}_{\sf GS} = -1.8 \mbox{ V}, \mbox{ I}_{\sf D} = -1.5 \mbox{ A}) \\ \end{array}$

#### **ORDERING INFORMATION**

PART NUMBER	PACKAGE	
μΡΑ1917ΤΕ	SC-95 (Mini Mold Thin Type)	

Marking : TR

#### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^{\circ}C$ )

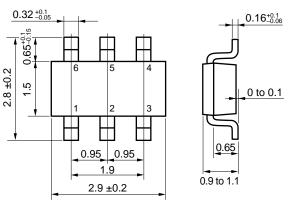
Drain to Source Voltage (VGs = 0 V)	VDSS	-20	V
Gate to Source Voltage (VDS = 0 V)	Vgss	∓8.0	V
Drain Current (DC) (T <sub>A</sub> = 25°C)	D(DC)	∓6.0	А
Drain Current (pulse) <sup>Note1</sup>	D(pulse)	∓24	А
Total Power Dissipation	PT1	0.2	W
Total Power Dissipation Note2	Рт2	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%

- **2.** Mounted on FR-4 board,  $t \le 5$  sec.
- **Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

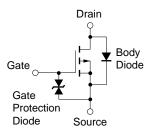
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#### PACKAGE DRAWING (Unit : mm)



1, 2, 5, 6 : Drain 3 : Gate 4 : Source

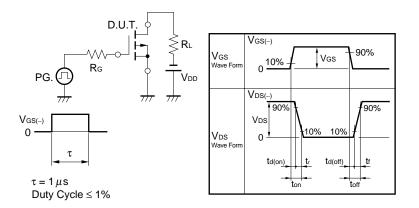
#### EQUIVALENT CIRCUIT



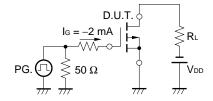
ELECTRICAL	CHARACTERISTICS ( $T_A = 25^{\circ}C$ )
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CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = -20 V, V_{GS} = 0 V$			-10	μA
Gate Leakage Current	lgss	$V_{GS} = \mp 8.0 \text{ V}, \text{ Vds} = 0 \text{ V}$			<b>∓10</b>	μA
Gate to Source Cut-off Voltage	VGS(off)	$V_{DS} = -10 \text{ V}, \text{ ID} = -1.0 \text{ mA}$	-0.45	-0.75	-1.5	V
Forward Transfer Admittance	y <sub>fs</sub>	Vds = -10 V, Id = -3.0 A	5.0	10.4		S
Drain to Source On-state Resistance	RDS(on)1	Vgs = −4.5 V, Id = −3.0 A		42	53	mΩ
	RDS(on)2	Vgs = −2.5 V, Id = −3.0 A		52	70	mΩ
	RDS(on)3	Vgs = −1.8 V, Id = −1.5 A		64	107	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = -10 V		835		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V		170		pF
Reverse Transfer Capacitance	Crss	f = 1.0 MHz		99		pF
Turn-on Delay Time	td(on)	$V_{DD} = -10 \text{ V}, \text{ ID} = -3.0 \text{ A}$		16		ns
Rise Time	tr	Vgs = -4.0 V		64		ns
Turn-off Delay Time	td(off)	R <sub>G</sub> = 10 Ω		78		ns
Fall Time	tr			108		ns
Total Gate Charge	Q <sub>G</sub>	V <sub>DD</sub> = -16 V		8.1		nC
Gate to Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = -4.0 V		1.3		nC
Gate to Drain Charge	Qgd	ID = -6.0 A		2.8		nC
Diode Forward Voltage	VF(S-D)	IF = 6.0 A, VGS = 0 V		0.94		V

#### **TEST CIRCUIT 1 SWITCHING TIME**



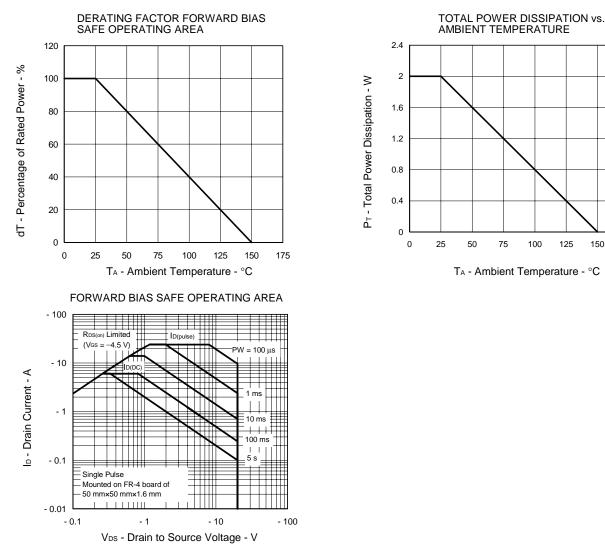
#### **TEST CIRCUIT 2 GATE CHARGE**



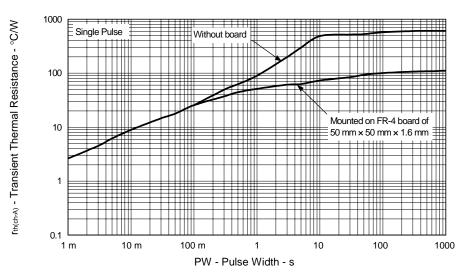
150

175

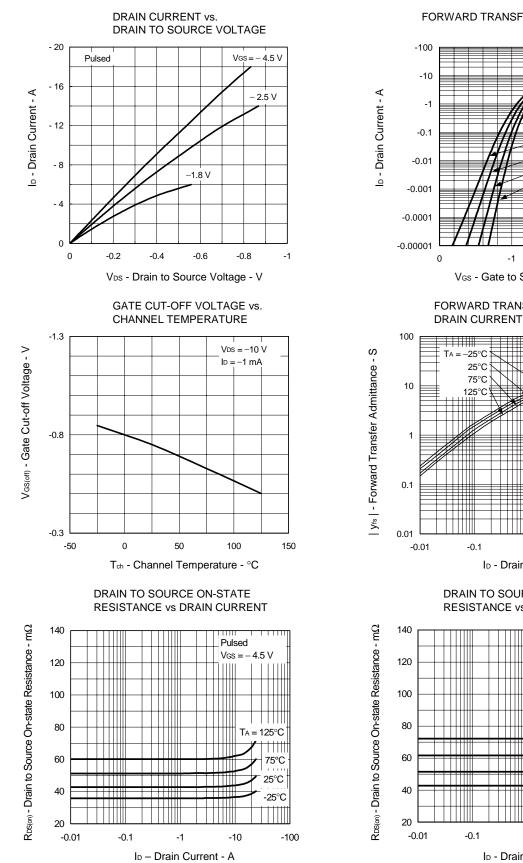
#### TYPICAL CHARACTERISTICS (TA = 25°C)



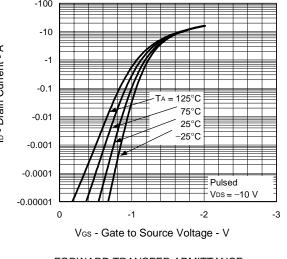
#### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



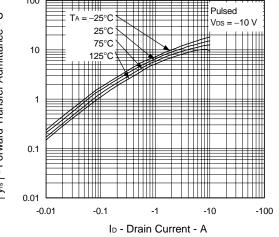
Data Sheet G15925EJ1V0DS



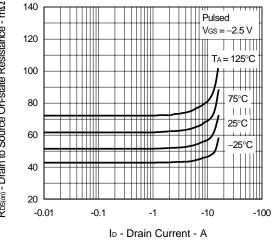
FORWARD TRANSFER CHARACTERISTICS



FORWARD TRANSFER ADMITTANCE vs.

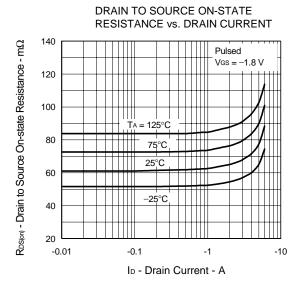


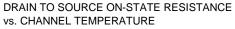
DRAIN TO SOURCE ON-STATE **RESISTANCE vs.DRAIN CURRENT** 

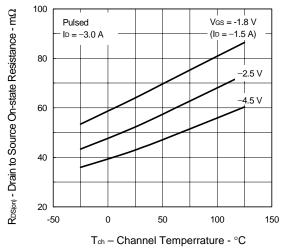


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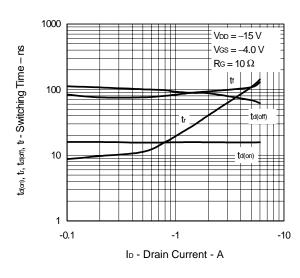
Data Sheet G15925EJ1V0DS



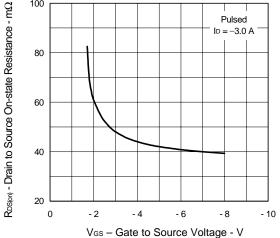




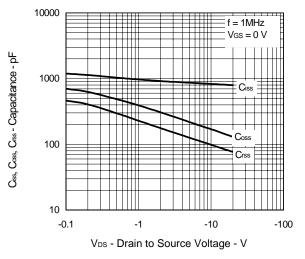




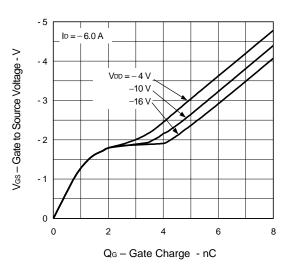
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE 100 Pulsed ID = -3.0 A



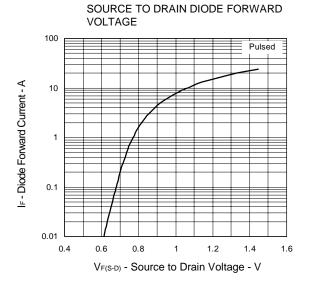








Data Sheet G15925EJ1V0DS



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